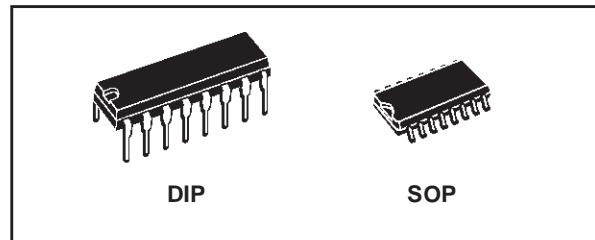


## 4-BIT MAGNITUDE COMPARATOR

- QUIESCENT CURRENT SPECIFIED UP TO 20V
- STANDARD B-SERIES OUTPUT DRIVE
- EXPANSION TO 8-16....4 N BITS BY CASCADING UNIT
- MEDIUM SPEED OPERATION : COMPARES TWO 4-BIT WORDS IN 250ns (Typ.) at 10V
- 5V, 10V AND 15V PARAMETRIC RATINGS
- INPUT LEAKAGE CURRENT  
 $I_I = 100\text{nA}$  (MAX) AT  $V_{DD} = 18\text{V}$   $T_A = 25^\circ\text{C}$
- 100% TESTED FOR QUIESCENT CURRENT
- MEETS ALL REQUIREMENTS OF JEDEC JESD13B " STANDARD SPECIFICATIONS FOR DESCRIPTION OF B SERIES CMOS DEVICES"



## ORDER CODES

PACKAGE	TUBE	T & R
DIP	HCF4063BEY	
SOP	HCF4063BM1	HCF4063M013TR

## DESCRIPTION

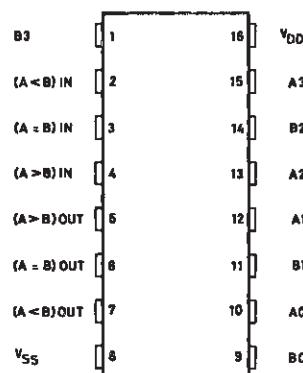
The HCF4063B is a monolithic integrated circuit fabricated in Metal Oxide Semiconductor technology available in DIP and SOP packages. The HCF4063B is a low power 4-bit magnitude comparator designed for use in computer and logic applications that require the comparison of two 4-bit words. This logic circuit determines whether one 4-bit word (Binary or BCD) is "less than", "equal to" or "greater than" a second 4 bit word. The HCF4063B has eight comparing inputs ( $A_3, B_3$  through  $A_0, B_0$ ), three outputs ( $A < B, A = B, A > B$ ) and three cascading inputs ( $A < B, A = B, A > B$ )

that permit system s designers to expand the comparator function to 8, 12, 16...4N bits. When a single HCF4063B is used the cascading inputs are connected as follows :

( $A < B$ ) = low, ( $A = B$ ) = high, ( $A > B$ ) = low.

For words longer than 4 bits, HCF4063B device may be cascaded by connecting the outputs of the less-significant comparator to the corresponding cascading inputs of the more significant comparator. Cascading inputs ( $A < B, A = B$ , and  $A > B$ ) on the least significant comparator are connected to a low, a high, and a low level, respectively.

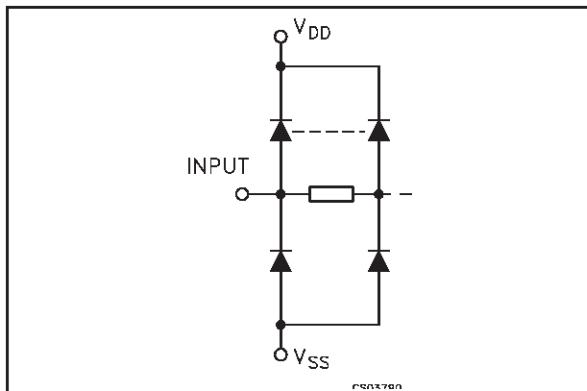
## PIN CONNECTION



5-1408/1

# HCF4063B

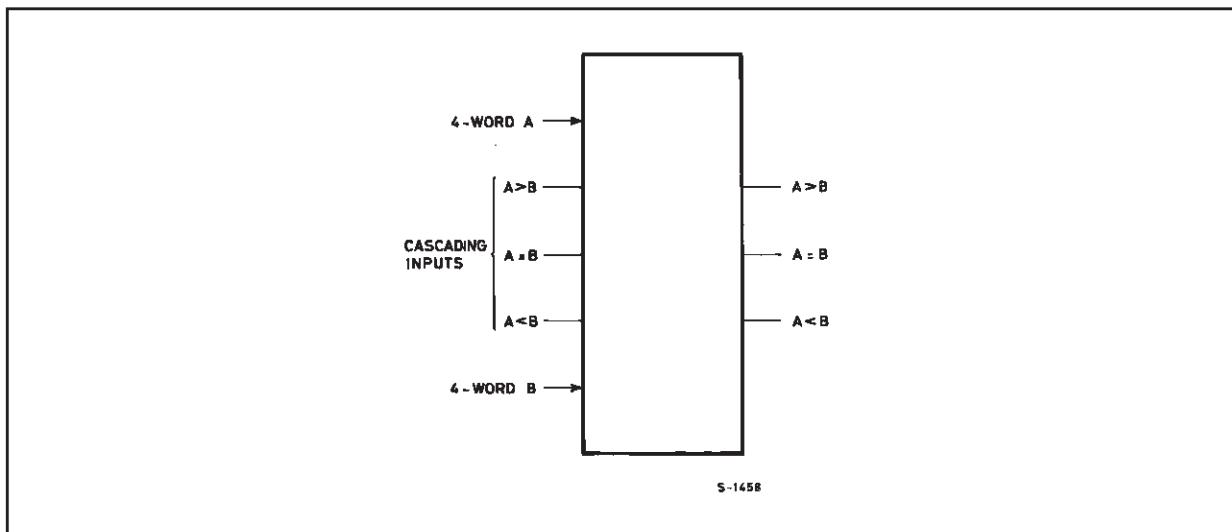
## I INPUT EQUIVALENT CIRCUIT



## PIN DESCRIPTION

PIN No	SYMBOL	NAME AND FUNCTION
10, 12, 13, 15	A0 to A3	Word A Inputs
9, 11, 14, 1	B0 to B3	Word B Inputs
5, 6 ,7	A>B, A=B, A<B	Outputs
4, 3, 2	A>B, A=B, A<B	Cascading Inputs
8	V <sub>SS</sub>	Negative Supply Voltage
16	V <sub>DD</sub>	Positive Supply Voltage

## FUNCTIONAL DIAGRAM

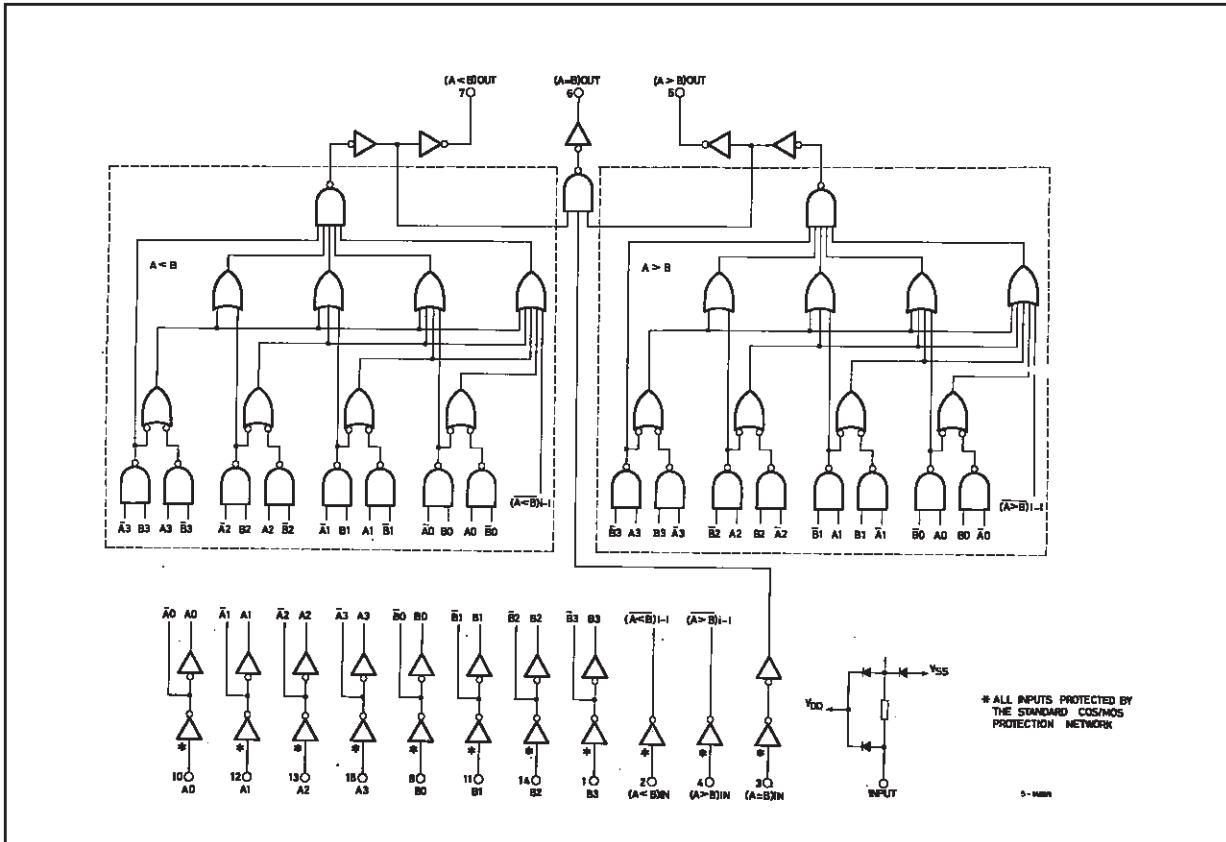


## TRUTH TABLE

INPUTS				OUTPUTS					
COMPARING				CASCAADING					
A3, B3	A2, B2	A1, B1	A0, B0	A<B	A=B	A>B	A<B	A=B	A>B
A3 > B3	X	X	X	X	X	X	L	L	H
A3 = B3	A2 > B2	X	X	X	X	X	L	L	H
A3 = B3	A2 = B2	A1 > B1	X	X	X	X	L	L	H
A3 = B3	A2 = B2	A1 = B1	A0 > B0	X	X	X	L	L	H
A3 = B3	A2 = B2	A1 = B1	A0 = B0	L	L	H	L	L	H
A3 = B3	A2 = B2	A1 = B1	A0 = B0	L	H	L	L	H	L
A3 = B3	A2 = B2	A1 = B1	A0 = B0	H	L	L	H	L	L
A3 = B3	A2 = B2	A1 = B1	A0 < B0	X	X	X	H	L	L
A3 = B3	A2 = B2	A1 < B1	X	X	X	X	H	L	L
A3 = B3	A2 < B2	X	X	X	X	X	H	L	L
A3 < B3	X	X	X	X	X	X	H	L	L

X : Don't Care

## LOGIC DIAGRAM



## ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
$V_{DD}$	Supply Voltage	-0.5 to +22	V
$V_I$	DC Input Voltage	-0.5 to $V_{DD} + 0.5$	V
$I_I$	DC Input Current	$\pm 10$	mA
$P_D$	Power Dissipation per Package	200	mW
	Power Dissipation per Output Transistor	100	mW
$T_{op}$	Operating Temperature	-55 to +125	°C
$T_{stg}$	Storage Temperature	-65 to +150	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied.

All voltage values are referred to  $V_{SS}$  pin voltage.

## RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
$V_{DD}$	Supply Voltage	3 to 20	V
$V_I$	Input Voltage	0 to $V_{DD}$	V
$T_{op}$	Operating Temperature	-55 to 125	°C

**DC SPECIFICATIONS**

Symbol	Parameter	Test Condition				Value						Unit	
		$V_I$ (V)	$V_O$ (V)	$ I_{OL} $ ( $\mu$ A)	$V_{DD}$ (V)	$T_A = 25^\circ C$			$-40 \text{ to } 85^\circ C$		$-55 \text{ to } 125^\circ C$		
						Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
$I_L$	Quiescent Current	0/5			5		0.04	5		150		150	$\mu A$
		0/10			10		0.04	10		300		300	
		0/15			15		0.04	20		600		600	
		0/20			20		0.08	100		3000		3000	
$V_{OH}$	High Level Output Voltage	0/5		<1	5	4.95			4.95		4.95		V
		0/10		<1	10	9.95			9.95		9.95		
		0/15		<1	15	14.95			14.95		14.95		
$V_{OL}$	Low Level Output Voltage	5/0		<1	5		0.05			0.05		0.05	V
		10/0		<1	10		0.05			0.05		0.05	
		15/0		<1	15		0.05			0.05		0.05	
$V_{IH}$	High Level Input Voltage	0.5/4.5	<1	5	3.5				3.5		3.5		V
		1/9	<1	10	7				7		7		
		1.5/13.5	<1	15	11				11		11		
$V_{IL}$	Low Level Input Voltage	4.5/0.5	<1	5			1.5			1.5		1.5	V
		9/1	<1	10			3			3		3	
		13.5/1.5	<1	15			4			4		4	
$I_{OH}$	Output Drive Current	0/5	2.5	<1	5	-1.36	-3.2		-1.1		-1.1		mA
		0/5	4.6	<1	5	-0.44	-1		-0.36		-0.36		
		0/10	9.5	<1	10	-1.1	-2.6		-0.9		-0.9		
		0/15	13.5	<1	15	-3.0	-6.8		-2.4		-2.4		
$I_{OL}$	Output Sink Current	0/5	0.4	<1	5	0.44	1		0.36		0.36		mA
		0/10	0.5	<1	10	1.1	2.6		0.9		0.9		
		0/15	1.5	<1	15	3.0	6.8		2.4		2.4		
$I_I$	Input Leakage Current	0/18	Any Input	18		$\pm 10^{-5}$	$\pm 0.1$		$\pm 1$		$\pm 1$		$\mu A$
$C_I$	Input Capacitance		Any Input			5	7.5						pF

The Noise Margin for both "1" and "0" level is: 1V min. with  $V_{DD}=5V$ , 2V min. with  $V_{DD}=10V$ , 2.5V min. with  $V_{DD}=15V$

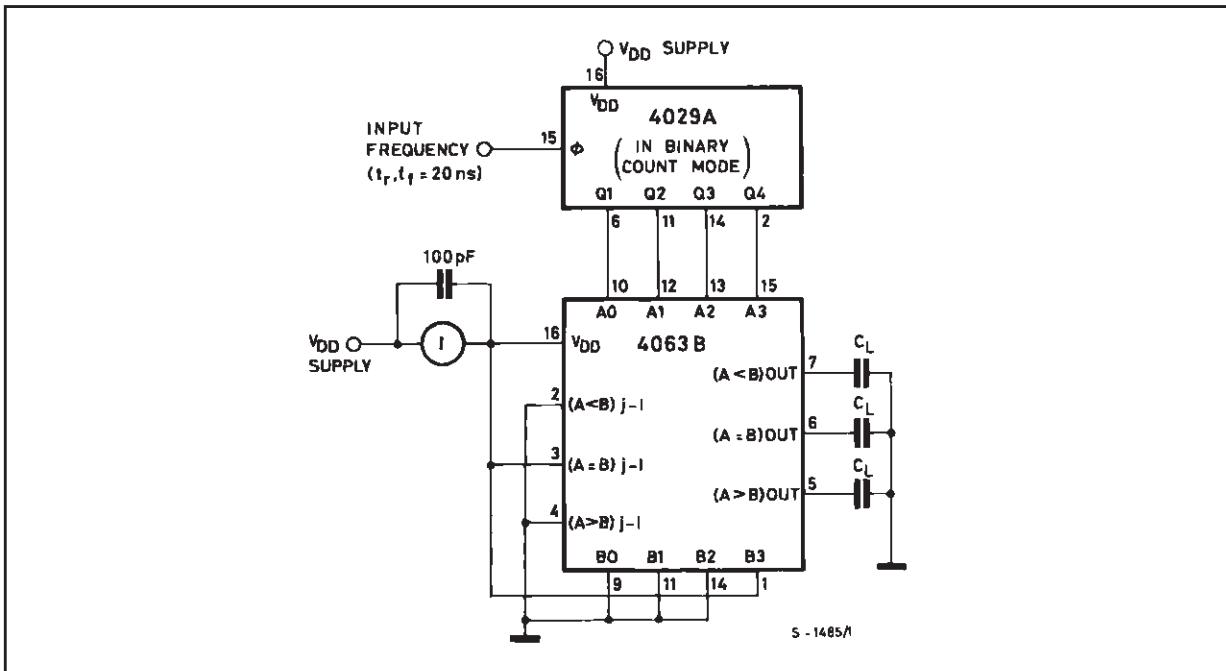
**DYNAMIC ELECTRICAL CHARACTERISTICS ( $T_{amb} = 25^\circ C$ ,  $C_L = 50pF$ ,  $R_L = 200K\Omega$ ,  $t_r = t_f = 20 \text{ ns}$ )**

Symbol	Parameter	Test Condition				Value (*)			Unit
		$V_{DD}$ (V)				Min.	Typ.	Max.	
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time	5	Comparing Inputs to Outputs				625	1250	ns
		10					250	500	
		15					175	350	
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time	5	Cascading Inputs to Outputs				500	1000	ns
		10					200	400	
		15					140	280	
$t_{THL}$ $t_{TLH}$	Transition Time	5					100	200	ns
		10					50	100	
		15					40	80	

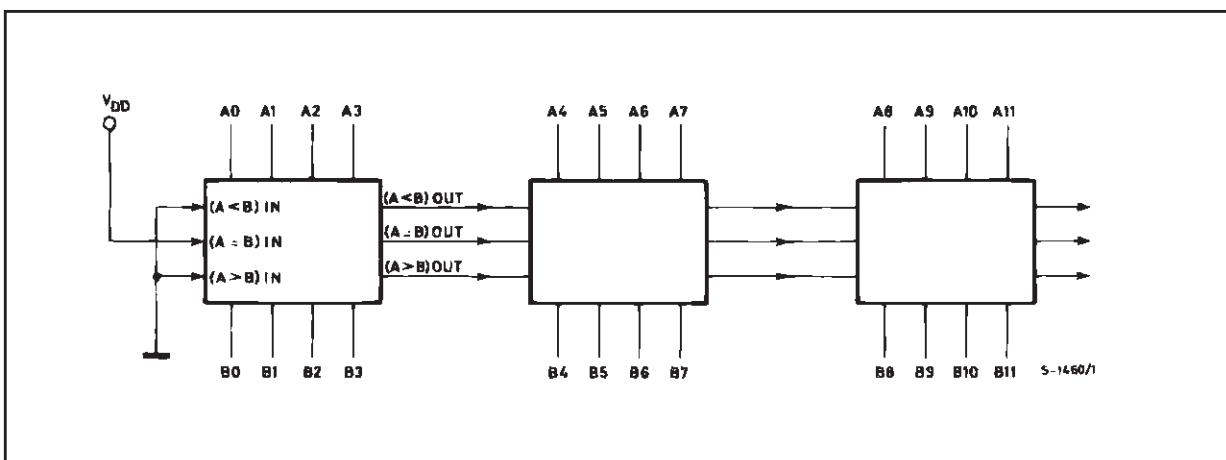
(\*) Typical temperature coefficient for all  $V_{DD}$  value is 0.3 %/ $^\circ C$ .

## TYPICAL APPLICATIONS

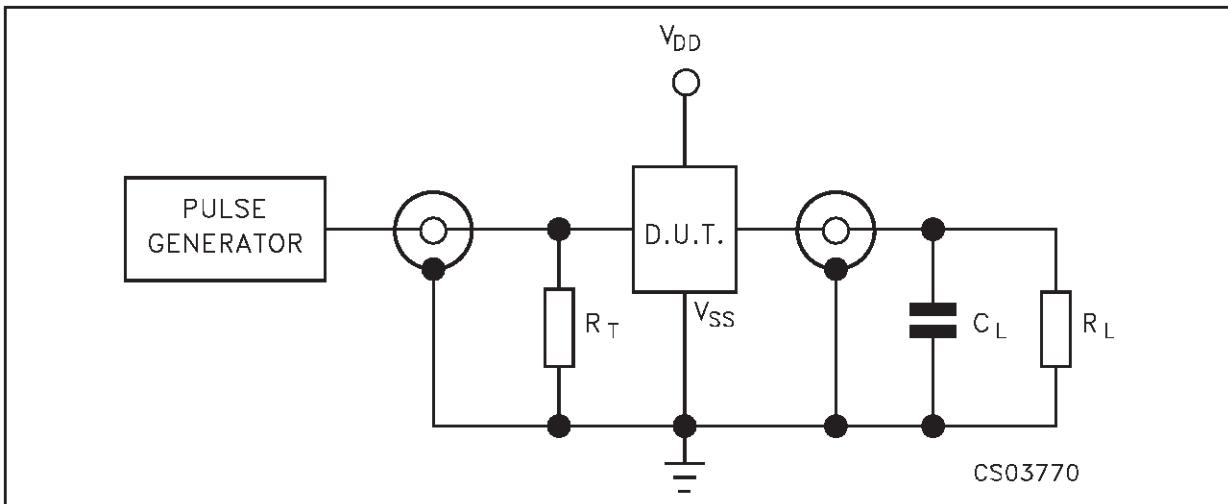
## DINAMIC POWER DISSIPATION



## TYPICAL SPEED CHARACTERISTICS OF A 12-BIT COMPARATOR



TEST CIRCUIT

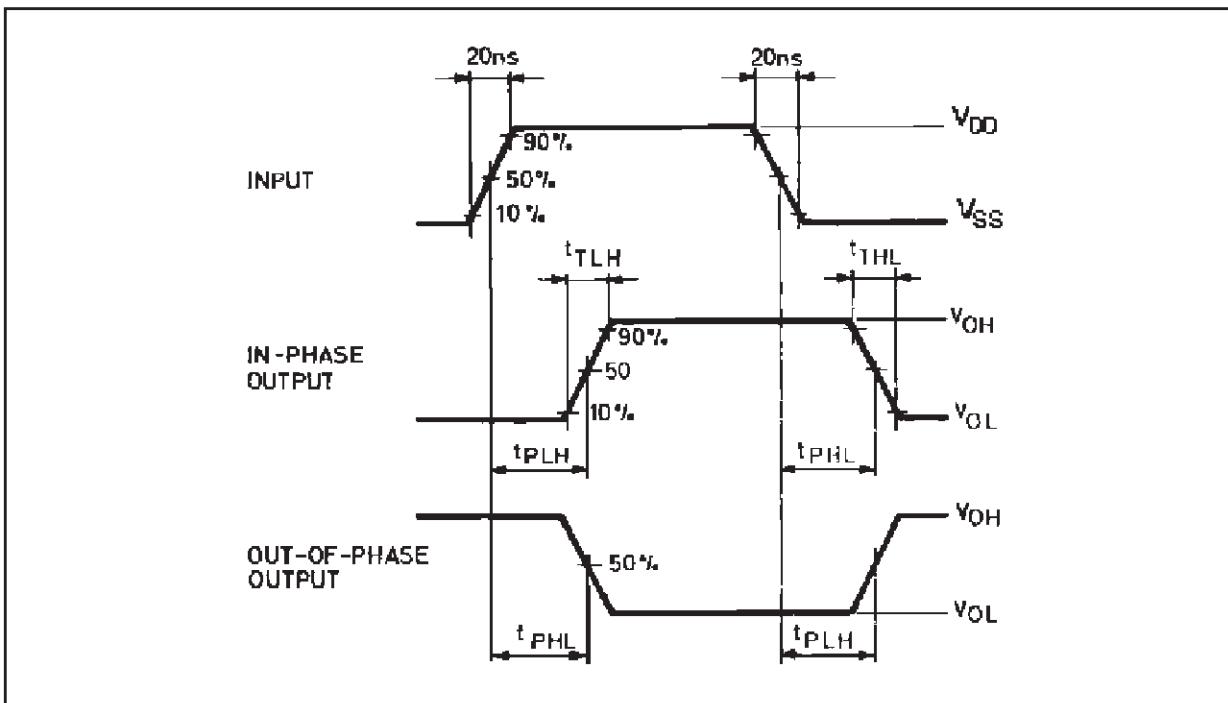


$C_L = 50\text{pF}$  or equivalent (includes jig and probe capacitance)

$R_L = 200\text{K}\Omega$

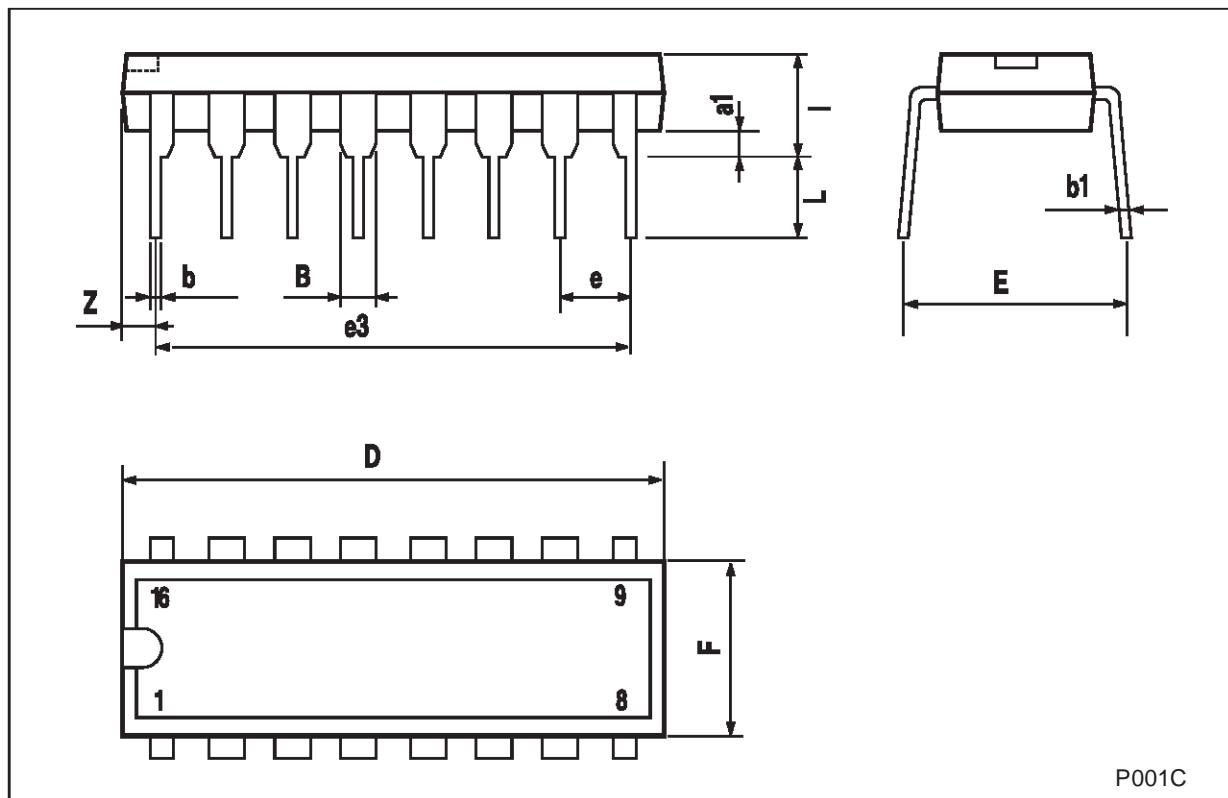
$R_T = Z_{\text{OUT}}$  of pulse generator (typically  $50\Omega$ )

WAVEFORM : PROPAGATION DELAY TIMES (f=1MHz; 50% duty cycle)



<b>Plastic DIP-16 (0.25) MECHANICAL DATA</b>
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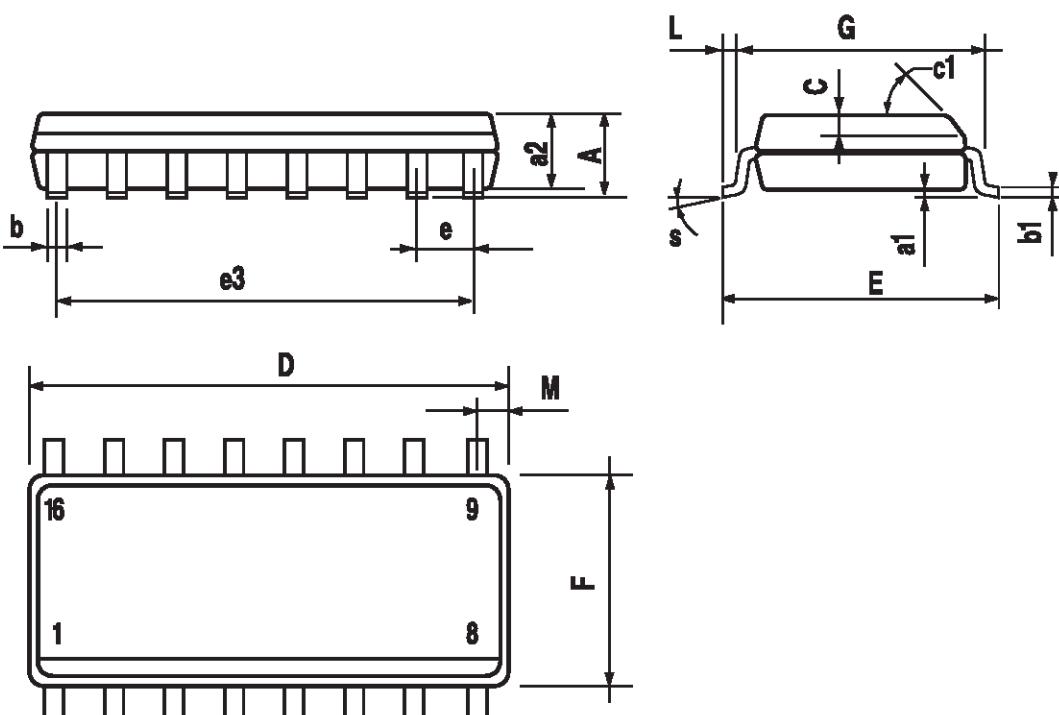
DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
a1	0.51			0.020		
B	0.77		1.65	0.030		0.065
b		0.5			0.020	
b1		0.25			0.010	
D			20			0.787
E		8.5			0.335	
e		2.54			0.100	
e3		17.78			0.700	
F			7.1			0.280
I			5.1			0.201
L		3.3			0.130	
Z			1.27			0.050



P001C

## SO-16 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.2	0.003		0.007
a2			1.65			0.064
b	0.35		0.46	0.013		0.018
b1	0.19		0.25	0.007		0.010
C		0.5			0.019	
c1	45° (typ.)					
D	9.8		10	0.385		0.393
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		8.89			0.350	
F	3.8		4.0	0.149		0.157
G	4.6		5.3	0.181		0.208
L	0.5		1.27	0.019		0.050
M			0.62			0.024
S	8° (max.)					



PO13H

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